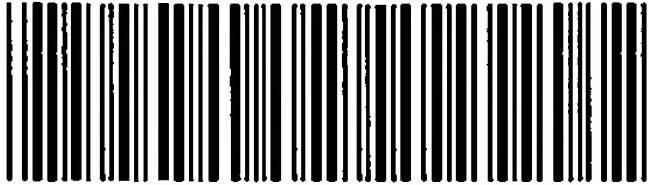


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/621,985	HSIEH ET AL.	
	Examiner	Art Unit	
	Stephen Yam	2878	

SEARCHED			
Class	Subclass	Date	Examiner
250	239, 216, 208.1	7/31/2005	SY
257	431-434	7/31/2005	SY
	680	7/31/2005	SY
359	827	7/31/2005	SY

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Keyword (see attached)	7/31/2005	SY
Class 257/222, 291, 678; 359/827 w/ keyword	7/31/2005	SY